MOSFETs Silicon N-Channel MOS (DTMOSIV)

## TK8P65W

## 1. Applications

- Switching Voltage Regulators


## 2. Features

(1) Low drain-source on-resistance: $\mathrm{R}_{\mathrm{DS}(\mathrm{ON})}=0.55 \Omega$ (typ.)
by used to Super Junction Structure : DTMOS
(2) Easy to control Gate switching
(3) Enhancement mode: $\mathrm{V}_{\text {th }}=2.5$ to $3.5 \mathrm{~V}\left(\mathrm{~V}_{\mathrm{DS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=0.3 \mathrm{~mA}\right)$

## 3. Packaging and Internal Circuit


4. Absolute Maximum Ratings (Note) $\left(\mathrm{T}_{\mathrm{a}}=25^{\circ} \mathrm{C}\right.$ unless otherwise specified)

| Characteristics |  | Symbol | Rating | Unit |
| :---: | :---: | :---: | :---: | :---: |
| Drain-source voltage |  | $\mathrm{V}_{\text {DSS }}$ | 650 | V |
| Gate-source voltage |  | $\mathrm{V}_{\text {GSS }}$ | $\pm 30$ |  |
| Drain current (DC) | (Note 1) | $I_{\text {D }}$ | 7.8 | A |
| Drain current (pulsed) | (Note 1) | $\mathrm{I}_{\mathrm{DP}}$ | 31.2 |  |
| Power dissipation $\quad\left(T_{C}=25^{\circ} \mathrm{C}\right)$ |  | $\mathrm{P}_{\mathrm{D}}$ | 80 | W |
| Single-pulse avalanche energy | (Note 2) | $\mathrm{E}_{\text {AS }}$ | 102 | mJ |
| Avalanche current |  | $\mathrm{I}_{\text {AR }}$ | 1.9 | A |
| Reverse drain current (DC) | (Note 1) | $\mathrm{I}_{\mathrm{DR}}$ | 7.8 |  |
| Reverse drain current (pulsed) | (Note 1) | IDRP | 31.2 |  |
| Channel temperature |  | $\mathrm{T}_{\mathrm{ch}}$ | 150 | ${ }^{\circ} \mathrm{C}$ |
| Storage temperature |  | $\mathrm{T}_{\text {stg }}$ | -55 to 150 |  |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

## 5. Thermal Characteristics

|  | Characteristics | Symbol | Max |
| :--- | :---: | :---: | :---: |
| Unit |  |  |  |
| Channel-to-case thermal resistance |  | $\mathrm{R}_{\mathrm{th}(\mathrm{ch}-\mathrm{c})}$ | 1.57 |

Note 1: Ensure that the channel temperature does not exceed $150^{\circ} \mathrm{C}$.
Note 2: $\mathrm{V}_{\mathrm{DD}}=90 \mathrm{~V}, \mathrm{~T}_{\mathrm{ch}}=25^{\circ} \mathrm{C}$ (initial), $\mathrm{L}=50.1 \mathrm{mH}, \mathrm{R}_{\mathrm{G}}=25 \Omega, \mathrm{I}_{\mathrm{AR}}=1.9 \mathrm{~A}$

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.
6. Electrical Characteristics

### 6.1. Static Characteristics ( $\mathrm{T}_{\mathrm{a}}=25^{\circ} \mathrm{C}$ unless otherwise specified)

| Characteristics | Symbol | Test Condition | Min | Typ. | Max | Unit |
| :--- | :---: | :--- | :---: | :---: | :---: | :---: |
| Gate leakage current | $\mathrm{I}_{\mathrm{GSS}}$ | $\mathrm{V}_{\mathrm{GS}}= \pm 30 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ | - | - | $\pm 1$ | $\mu \mathrm{~A}$ |
| Drain cut-off current | $\mathrm{I}_{\mathrm{DSS}}$ | $\mathrm{V}_{\mathrm{DS}}=650 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | - | - | 10 |  |
| Drain-source breakdown voltage | $\mathrm{V}_{(\mathrm{BR}) \mathrm{DSS}}$ | $\mathrm{I}_{\mathrm{D}}=10 \mathrm{~mA}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | 650 | - | - | V |
| Gate threshold voltage | $\mathrm{V}_{\mathrm{th}}$ | $\mathrm{V}_{\mathrm{DS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=0.3 \mathrm{~mA}$ | 2.5 | - | 3.5 |  |
| Drain-source on-resistance | $\mathrm{R}_{\mathrm{DS}(\mathrm{ON})}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=3.9 \mathrm{~A}$ | - | 0.55 | 0.67 | $\Omega$ |

### 6.2. Dynamic Characteristics ( $\mathrm{T}_{\mathrm{a}}=25^{\circ} \mathrm{C}$ unless otherwise specified)

| Characteristics | Symbol | Test Condition | Min | Typ. | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Input capacitance | $\mathrm{C}_{\text {iss }}$ | $\mathrm{V}_{\mathrm{DS}}=300 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ | - | 570 | - | pF |
| Reverse transfer capacitance | $\mathrm{C}_{\text {rss }}$ |  | - | 2.5 | - |  |
| Output capacitance | $\mathrm{C}_{\text {oss }}$ |  | - | 16 | - |  |
| Effective output capacitance | $\mathrm{C}_{\text {o(er) }}$ | $\mathrm{V}_{\mathrm{DS}}=0$ to $400 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | - | 23 | - |  |
| Gate resistance | $\mathrm{r}_{\mathrm{g}}$ | $\mathrm{V}_{\mathrm{DS}}=\mathrm{OPEN}, \mathrm{f}=1 \mathrm{MHz}$ | - | 7.5 | - | $\Omega$ |
| Switching time (rise time) | $\mathrm{t}_{\mathrm{r}}$ | See Figure 6.2.1 | - | 20 | - | ns |
| Switching time (turn-on time) | $\mathrm{t}_{\text {on }}$ |  | - | 40 | - |  |
| Switching time (fall time) | $t_{f}$ |  | - | 4 | - |  |
| Switching time (turn-off time) | $\mathrm{t}_{\text {off }}$ |  | - | 60 | - |  |
| MOSFET dv/dt ruggedness | $\mathrm{dv} / \mathrm{dt}$ | $\mathrm{V}_{\mathrm{DD}}=0$ to $400 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=3.9 \mathrm{~A}$ | 50 | - | - | V/ns |



Fig. 6.2.1 Switching Time Test Circuit

### 6.3. Gate Charge Characteristics ( $\mathrm{T}_{\mathrm{a}}=25^{\circ} \mathrm{C}$ unless otherwise specified)

| Characteristics | Symbol | Test Condition | Min | Typ. | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Total gate charge (gate-source plus gate-drain) | $\mathrm{Q}_{\mathrm{g}}$ | $\mathrm{V}_{\mathrm{DD}} \approx 400 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=7.8 \mathrm{~A}$ | - | 16 | - | nC |
| Gate-source charge 1 | $\mathrm{Q}_{\mathrm{gs} 1}$ |  | - | 4 | - |  |
| Gate-drain charge | $\mathrm{Q}_{\mathrm{gd}}$ |  | - | 7.5 | - |  |

### 6.4. Source-Drain Characteristics ( $\mathrm{T}_{\mathrm{a}}=25^{\circ} \mathrm{C}$ unless otherwise specified)

| Characteristics | Symbol | Test Condition | Min | Typ. | Max | Unit |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
| Diode forward voltage | $\mathrm{V}_{\mathrm{DSF}}$ | $\mathrm{I}_{\mathrm{DR}}=7.8 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | - | - | -1.7 | V |
| Reverse recovery time | $\mathrm{t}_{\mathrm{rr}}$ | $\mathrm{I}_{\mathrm{DR}}=3.9 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | - | 210 | - | ns |
| Reverse recovery charge | $\mathrm{Q}_{\mathrm{rr}}$ | $-\mathrm{d} \mathrm{I}_{\mathrm{DR}} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$ | - | 1.7 | - | $\mu \mathrm{C}$ |
| Peak reverse recovery current |  | $\mathrm{I}_{\mathrm{rr}}$ |  | - | 17 | - |
| Diode dv/dt ruggedness | $\mathrm{dv} / \mathrm{dt}$ | $\mathrm{I}_{\mathrm{DR}}=3.9 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DD}}=400 \mathrm{~V}$ | 15 | - | - | $\mathrm{A} / \mathrm{ns}$ |

7. Marking


Fig. 7.1 Marking
8. Characteristics Curves (Note)


Fig. 8.1 $I_{D}-V_{D S}$


Fig. $8.3 \quad I_{D}-V_{G S}$


Fig. 8.5 $V_{D S S}-T_{a}$


Fig. 8.2 $I_{D}-V_{D S}$


Fig. 8.4 $V_{D S}-V_{G S}$


Fig. 8.6 $R_{D S(O N)}-I_{D}$


Fig. 8.7 $R_{D S(O N)}-T_{a}$


Fig. 8.9 $C-V_{D S}$


Fig. 8.11 $V_{\text {th }}-T_{a}$


Fig. 8.8 $I_{D R}-V_{D S}$


Fig. 8.10 Eoss - $V_{D S}$


Fig. 8.12 Dynamic Input/Output Characteristics


Fig. $8.13 r_{\text {th }}-t_{w}$
(Guaranteed Maximum)


Fig. $8.14 \mathrm{E}_{\mathrm{AS}}-\mathrm{T}_{\mathrm{ch}}$ (Guaranteed Maximum)


Fig. 8.15 $\mathrm{PD}_{\mathrm{D}}-\mathrm{T}_{\mathrm{C}}$
(Guaranteed Maximum)


Test circuit Waveform
$R_{G}=25 \Omega, V_{D D}=90 \vee E_{A S}=\frac{1}{2} \cdot L \cdot I^{2}{ }_{A R} \cdot\left(\frac{B V D S S}{B V D S S-V_{D D}}\right)$
Fig. 8.16 Test Circuit/Waveform


Fig. 8.17 Safe Operating Area (Guaranteed Maximum)

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

Package Dimensions


Weight: 0.36 g (typ.)

| Package Name(s) |  |
| :--- | :--- |
| TOSHIBA: 2-7K1S |  |
| Nickname: DPAK |  |

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